Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination LAI ET AL.	
10/803,666		
Examiner	Art Unit	
JOHN PAK	1616	

SEARCHED					
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INTERFERENCE SEARCHED					
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
Inventor names Searchel	3/07	W.		